Random bad cell map for wafer 172 s/n: Y21316-12-03

Date: 07/07/99

		1	0	0				
		0	0					
	1	0	0	10	0	10	0	
	0	0	0	1	37	0	0	
	0	0	4	2		0	0	0
0	0	0	6	16	8	0	0	0
0	0	0	14		34	1	8	0
0	0	0	25	23	69	4	0	0
0		0	28	3	51	1	0	
0		1	17	5		0	1	
0	0	0	7	6	17	0	0	0
26	0	0	7	26	11	0	0	0
0	0	0	0	5	0	0	0	0
	0	0	1	0	0	0	0	6
	0			0		0		
	0	0		0	0	0	0	
				0	1	0		
			0	0	0			

#	Number of bad cells in random locations
	No info